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Application/Control No.	Applicant(s)/Patent under Reexamination
10/784,716	ISHIHARA ET AL.
Examiner	Art Unit
John Q. Nguyen	3654

SEARCHED					
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INT	INTERFERENCE SEARCHED				
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pgpub interference search		7/3/2007	/JN/		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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